



SEMITRANS® 2

Trench IGBT Modules

SKM75GB07E3

Features*

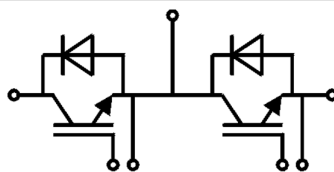
- $V_{CE(sat)}$ with positive temperature coefficient
- High short circuit capability, self limiting to $6 \times I_{Cnom}$
- Fast & soft switching inverse CAL diodes
- Insulated copper baseplate using DCB Technology (Direct Copper Bonding)
- With integrated gate resistor

Typical Applications

- AC inverter drives
- UPS
- Electronic welders
- Wind power
- Public transport

Remarks

- Case temperature limited to $T_c = 125^\circ\text{C}$ max.
- Recommended $T_{op} = -40 \dots +150^\circ\text{C}$
- Product reliability results valid for $T_j = 150^\circ\text{C}$
- Use of soft R_G necessary



GB

Absolute Maximum Ratings

Symbol	Conditions		Values	Unit
IGBT				
V _{CES}	T _J = 25 °C		650	V
I _C	T _J = 175 °C	T _c = 25 °C	99	A
		T _c = 80 °C	74	A
I _{Cnom}			75	A
I _{CRM}			225	A
V _{GES}			-20 ... 20	V
t _{psc}	V _{CC} = 360 V V _{GE} ≤ 15 V V _{CES} ≤ 650 V	T _J = 150 °C	6	μs
T _J			-40 ... 175	°C
Inverse diode				
V _{RRM}	T _J = 25 °C		650	V
I _F	T _J = 175 °C	T _c = 25 °C	84	A
		T _c = 80 °C	62	A
I _{FRM}			100	A
I _{FSM}	t _p = 10 ms, sin 180°, T _J = 25 °C		550	A
T _J			-40 ... 175	°C
Module				
I _{t(RMS)}			200	A
T _{stg}	module without TIM		-40 ... 125	°C
V _{isol}	AC sinus 50 Hz, t = 1 min		4000	V

Characteristics

Symbol	Conditions	min.	typ.	max.	Unit
IGBT					
$V_{CE(sat)}$	$I_C = 75\text{ A}$ $V_{GE} = 15\text{ V}$ chipelevel	$T_j = 25^\circ\text{C}$	1.45	1.77	V
		$T_j = 150^\circ\text{C}$	1.72	2.10	V
V_{CE0}	chipelevel	$T_j = 25^\circ\text{C}$	0.90	1.00	V
		$T_j = 150^\circ\text{C}$	0.82	0.90	V
r_{CE}	$V_{GE} = 15\text{ V}$ chipelevel	$T_j = 25^\circ\text{C}$	7.3	10	m Ω
		$T_j = 150^\circ\text{C}$	12	16	m Ω
$V_{GE(th)}$	$V_{GE} = V_{CE}$, $I_C = 1.2\text{ mA}$	5.1	5.8	6.4	V
I_{CES}	$V_{GE} = 0\text{ V}$, $V_{CE} = 650\text{ V}$, $T_j = 25^\circ\text{C}$			0.3	mA
C_{ies}	$V_{CE} = 25\text{ V}$ $V_{GE} = 0\text{ V}$	$f = 1\text{ MHz}$	4.6		nF
C_{oes}		$f = 1\text{ MHz}$	0.30		nF
C_{res}		$f = 1\text{ MHz}$	0.14		nF
Q_G	$V_{GE} = -8\text{ V} \dots +15\text{ V}$		680		nC
R_{Gint}	$T_j = 25^\circ\text{C}$		4.0		Ω
$t_{d(on)}$	$V_{CC} = 300\text{ V}$ $I_C = 75\text{ A}$ $V_{GE} = +15/-15\text{ V}$ $R_{Gon} = 1\text{ }\Omega$ $R_{Goff} = 1\text{ }\Omega$ $di/dt_{on} = 2500\text{ A}/\mu\text{s}$ $di/dt_{off} = 1250\text{ A}/\mu\text{s}$ $dv/dt = 4030\text{ V}/\mu\text{s}$	$T_j = 150^\circ\text{C}$	72		ns
t_r		$T_j = 150^\circ\text{C}$	30		ns
E_{on}		$T_j = 150^\circ\text{C}$	2.4		mJ
$t_{d(off)}$		$T_j = 150^\circ\text{C}$	250		ns
t_f		$T_j = 150^\circ\text{C}$	50		ns
E_{off}		$T_j = 150^\circ\text{C}$	2.7		mJ
$R_{th(j-c)}$	per IGBT			0.591	K/W
$R_{th(c-s)}$	per IGBT, P12 (reference)		0.090		K/W
$R_{th(c-s)}$	per IGBT, HP-PCM		0.050		K/W



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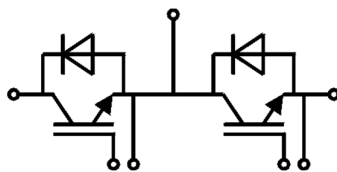
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Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
Inverse diode						
$V_F = V_{EC}$	$I_F = 75\text{ A}$ $V_{GE} = 0\text{ V}$ chipelevel	$T_J = 25\text{ }^{\circ}\text{C}$		1.37	1.73	V
		$T_J = 150\text{ }^{\circ}\text{C}$		1.35	1.72	V
V_{F0}	chipelevel	$T_J = 25\text{ }^{\circ}\text{C}$		1.04	1.24	V
		$T_J = 150\text{ }^{\circ}\text{C}$		0.85	0.99	V
r_F	chipelevel	$T_J = 25\text{ }^{\circ}\text{C}$		6.7	9.8	mΩ
		$T_J = 150\text{ }^{\circ}\text{C}$		10	15	mΩ
I_{RRM}	$V_{CC} = 300\text{ V}$ $I_F = 75\text{ A}$ $V_{GE} = -15\text{ V}$ $di/dt_{off} = 2740\text{ A}/\mu\text{s}$	$T_J = 150\text{ }^{\circ}\text{C}$		87		A
Q_{rr}		$T_J = 150\text{ }^{\circ}\text{C}$		7.8		μC
E_{rr}		$T_J = 150\text{ }^{\circ}\text{C}$		1.6		mJ
$R_{th(j-c)}$	per diode			0.85		K/W
$R_{th(c-s)}$	per diode, P12 (reference)			0.108		K/W
$R_{th(c-s)}$	per diode, HP-PCM			0.059		K/W
Module						
L_{CE}				30		nH
$R_{CC+EE'}$	measured per switch	$T_J = 25\text{ }^{\circ}\text{C}$		0.65		mΩ
		$T_J = 150\text{ }^{\circ}\text{C}$		1.09		mΩ
$R_{th(c-s)1}$	calculated without thermal coupling, P12 (reference)			0.025		K/W
$R_{th(c-s)2}$	including thermal coupling, T_s underneath module, P12 (reference)			0.040		K/W
$R_{th(c-s)2}$	including thermal coupling, T_s underneath module, HP-PCM			0.022		K/W
M_s	to heat sink M6		3		5	Nm
M_t		to terminal M5	2.5		5	Nm
				-		Nm
w					160	g



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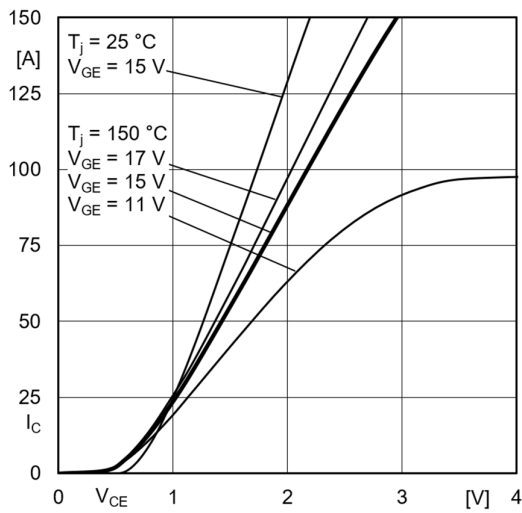


Fig. 1: Typ. output characteristic, inclusive $R_{CC'+EE'}$

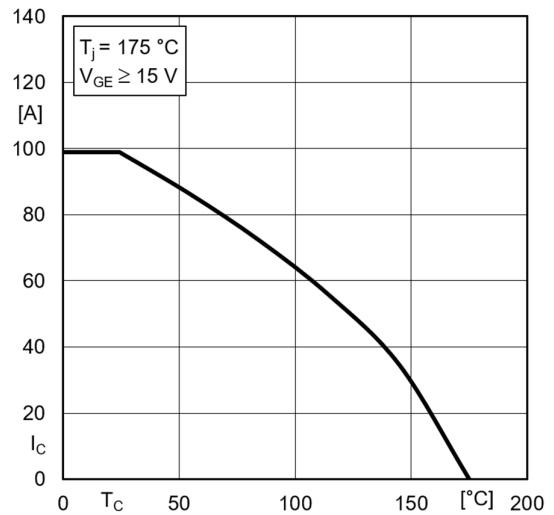


Fig. 2: Rated current vs. temperature $I_C = f(T_C)$

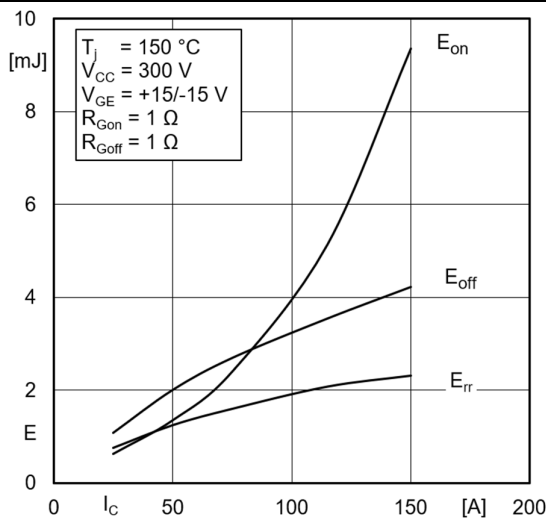


Fig. 3: Typ. turn-on /-off energy = $f(I_C)$

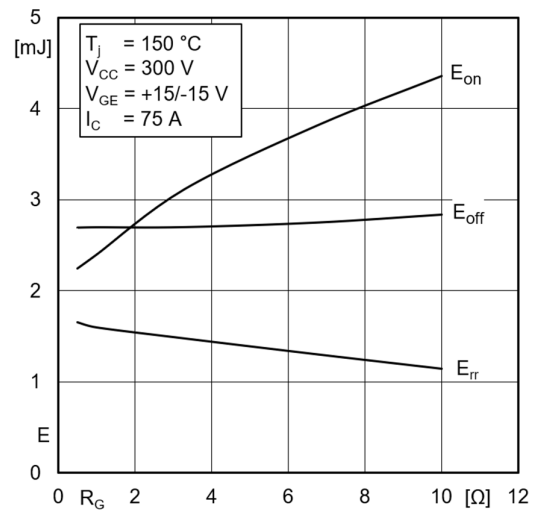


Fig. 4: Typ. turn-on /-off energy = $f(R_G)$

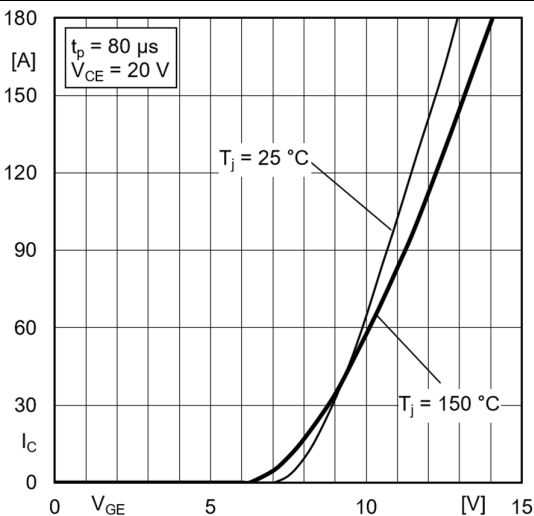


Fig. 5: Typ. transfer characteristic

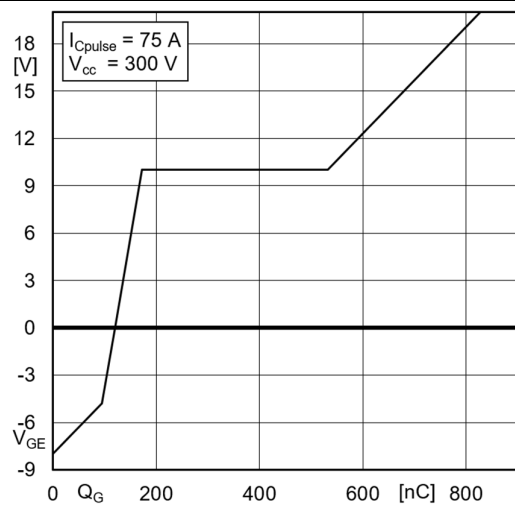


Fig. 6: Typ. gate charge characteristic

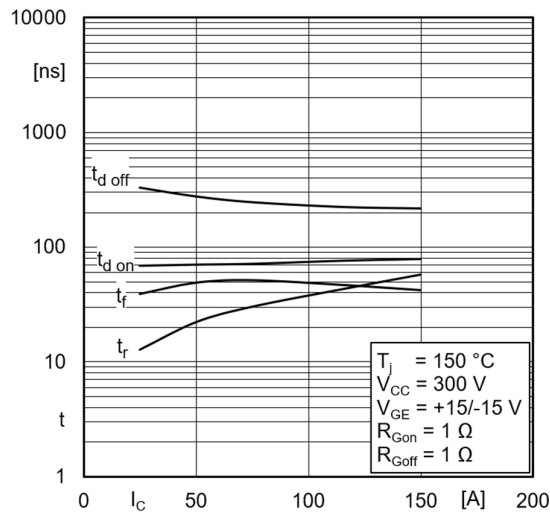


Fig. 7: Typ. switching times vs. I_C

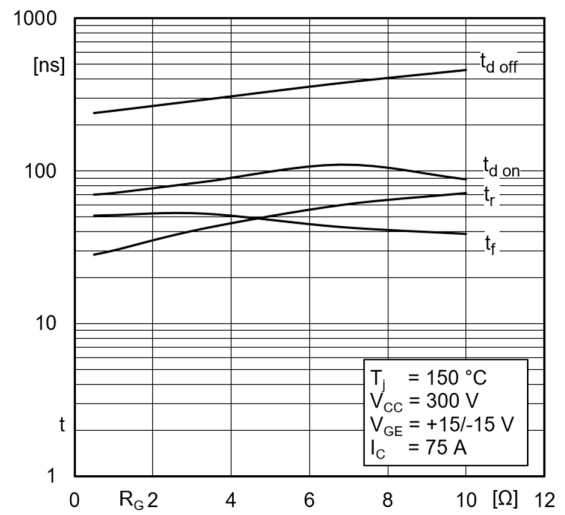


Fig. 8: Typ. switching times vs. gate resistor R_G

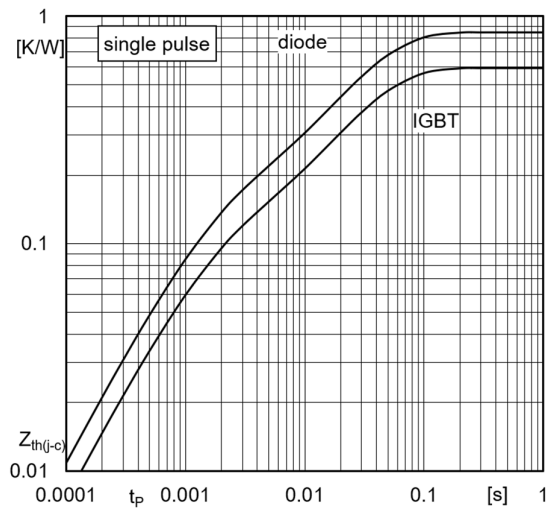


Fig. 9: Transient thermal impedance

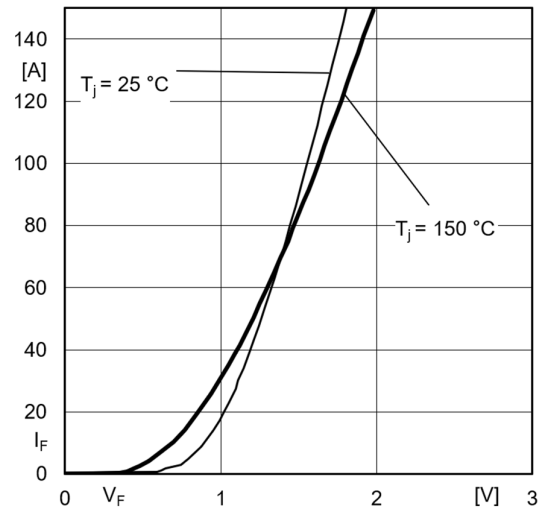


Fig. 10: Typ. CAL diode forward charact., incl. $R_{CC}+EE'$

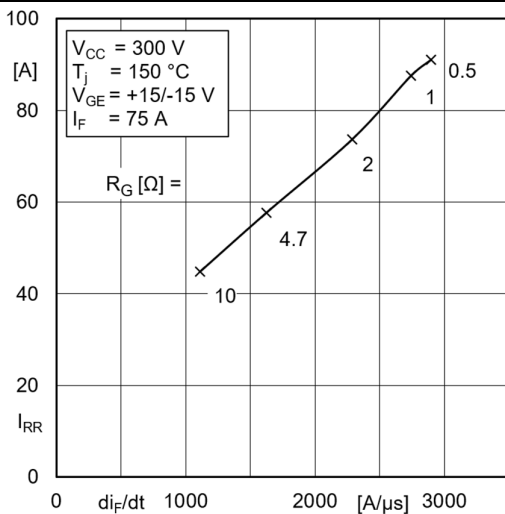


Fig. 11: CAL diode peak reverse recovery current

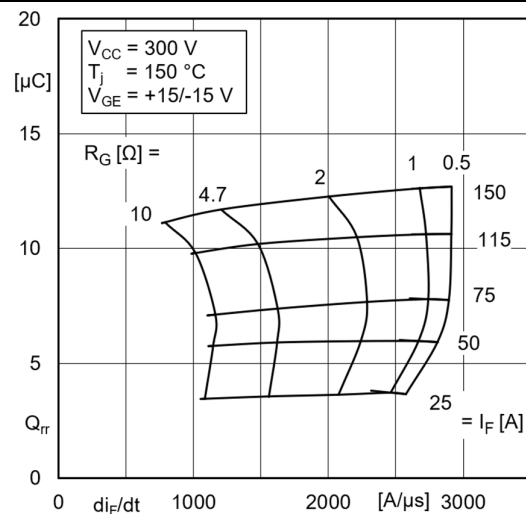
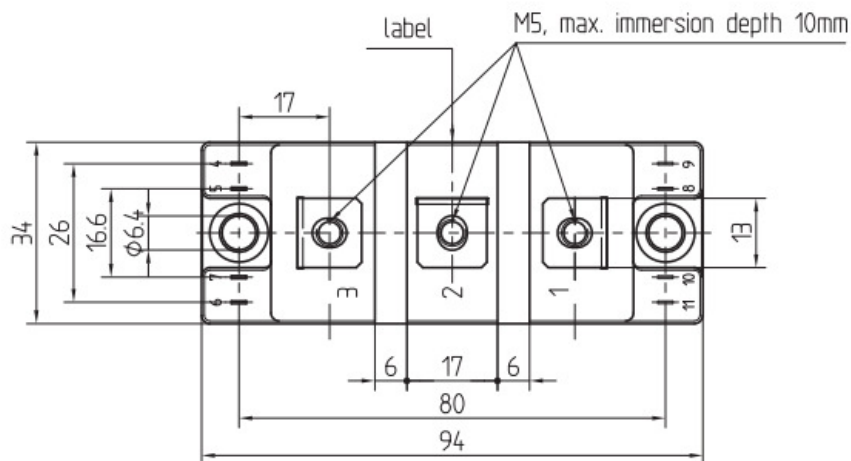
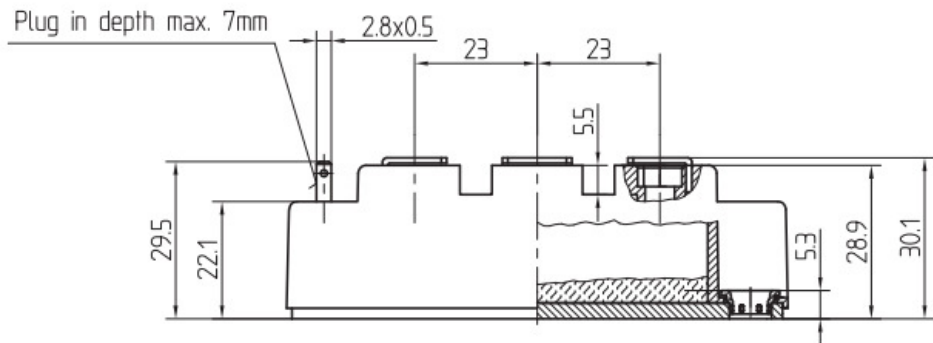


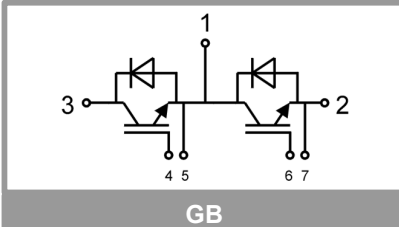
Fig. 12: Typ. CAL diode peak reverse recovery charge

Dimensions in mm



General tolerance ± 0.5 mm

Pinout and Dimensions



This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

*IMPORTANT INFORMATION AND WARNINGS

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